

PSE Technology Corporation

SPECIFICATION FOR APPROVAL

CUSTOMER	
NOMINAL FREQUENCY	32.768 KHz
PRODUCT TYPE	TYPE G9 SMD CRYSTAL
SPEC. NO. (P/N)	G93270004
CUSTOMER P/N	
ISSUE DATE	Oct.25,2013
VERSION	В

APPROVED	PREPARED	QA
Brenda	Clane	Bedrycri
APPROVED BY	APPROVED BY CUSTOMER:	
Please return one copy with approval to PSE-TW		

PSE Technology Corporation

No.2, Tzu-Chiang 5th Rd, Chung Li Industrial Park, Chung Li City, Taoyuan County, Taiwan (R.O.C.)

TEL: 886-3-451-8888 FAX: 886-3-461-3865

http://www.saronix-ecera.com.tw

*Pb-free

*RoHS Compliant

*HF-Halogen Free

*REACH Compliant



*** A company of PERICOM Semiconductor Corporation

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VERSION HISTORY

Version No.	Version Date	Customer Receipt Date	Supplier Receipt Date	Description	Notes
Α	Mar.19,2013			Initial Release	
В	Oct.25,2013			Revised to RoHS Compliant	

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ELECTRICAL SPECIFICATIONS

SRe Part Number: G93270004

Parameters	Symbol	Specifications	Units	Notes
Nominal Frequency	Fn	32.768	KHz	
Frequency Tolerance	FT	± 20	ppm	at 25°C ± 5°C
Load Capacitance	CL	12.5	pF	Тур.
Drive Level	DL	0.1 / 0.5	μW	Typ. / Max.
Equivalent Series Resistance	ESR	90	ΚΩ	Max.
Temperature Coefficient	K	-0.03	ppm/°C ²	Тур.
Operating Temperature Range	TR	-40~85	°C	
Shunt Capacitance	C0	1.3	pF	± 20%
Motional Capacitance	C1	6.4	fF	± 20%
Storage Temperature Range		-55~85	°C	
Aging		± 3	ppm	Max 1st year
Insulation Resistance		500	ΜΩ	Min.

Reliability (Mechanical and environmental performances)

No.	Test Items	Conditions	Requirements	
1	Bending test	Apply pressure in the direction of the arrow at a rate of about 0.5mm/s until bent width reaches 5mm, and hold for 30 seconds.	 Without mechanical damage such as breaks and satisfy sealing specification. Frequency change: Within ±5ppm Equivalent series resistance(E.S.R) change: Within 5kΩ 	
2	Shear test	A static load of 20N(2.04kgf) using a R0.5 scratch tool, shall be applied on the core of the component and in the direction of the arrow and held for 5 seconds.		
3	Core body strength	A static load of 10N(1.02kgf) using a R0.5 pressure rod shall be applied to the center in the direction of the arrow and held for 10 seconds.		
4	Vibration	Endurance conditioning by a frequency sweep shall be made. The entire frequency range, from 10Hz to 55Hz and return to 10Hz, shall be transversed in 1 minute. Amplitude (total excursion): 1.5mm, This motion shall be applied for a period of 2 hours in each of 3 mutually perpendicular axes (a total of 6 hours). For other procedures, refer to JIS C 60068-2-6.		
5	Shock	Peak acceleration: 9810m/s2, Duration of the pulse: 1ms, Three successive shock shall be applied 3 times perpendicular axes. For other procedures, refer to JIS C 60068-2-27.		

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Cold • Frequency change: Within ±5ppm Quartz crystal units shall be stored in the -40±3°C atmosphere for 1000 hours. Other procedures conform • Equivalent series resistance(E.S.R) to JIS C 60068-2-1. change: Within 5kΩ Dry heat Quartz crystal units shall be stored in the 100±2°C · After conditioning, quartz crystal units atmosphere for 100 hours. Other procedures conform to shall be subjected to standard atmospheric JIS C 60068-2-2. conditions for 1 hour, and measured. Damp heat Quartz crystal units shall be stored in the 40±2°C atmosphere with 90 to 95% relative humidity for 1000 hours. Other procedures conform to JIS C 60068-2-3. Change of Quartz crystal units shall be subjected successively 100 temperature cycles of temperature change shown below. Other procedures conform to JIS C 0025. Temperature Duration -40±3°C 30min. 2 Normal temperature Within 30 sec. 30min. 100±2°C Normal temperature Within 30 sec Sealing Both the test methods specified below shall be applied. Quartz crystal units shall be soaked in 90°C or higher · Without repetitive leaking bubbles from temperature hot water for 5 minutes. quartz crystal units. • 1×10-9 Pa·m3/s or less Quartz crystal units shall be tested by Mass spectrometric leakage detector to measure the leakage rate of helium gas. Aging Quartz crystal units shall be stored in the 85±3°C • Frequency change: Within ±5ppm atmosphere for 720±12 hours. Equivalent series resistance(E.S.R) change: Within 5kΩ • After conditioning, quartz crystal units shall be subjected to standard atmospheric conditions for 1 hour, and measured. Solder-ability Terminals coated with flux shall be immersed in the Minimum 95% of immersed terminal shall solder bath for 3.5±0.5 seconds. be covered with new uniform solder. Conditions Items Sn-3.0Ag-0.5Cu 1 Solder

Approximately 25wt% methanol(JIS K 8891)

solution of resin(JIS K

5902).

255±5℃

Flux

Solder

temperature

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Resistance to Reflow soldering method 温度プロファイル soldering heat Temperature profile はんだ付け Soldering 260 Soldering temperature 220 60±10s 徐冷(常温自然放置) Slow cooling(Stored Pre-heating at room temperature) 160 Within 5s $90 \pm 10s$ • Frequency change: Within ±5ppm Peak temperature: 260±5°C for within 5seconds. • Equivalent series resistance (E.S.R) Soldering temperature: 220°C or higher for 60±10 change: Within 10kΩ seconds. · After conditioning, quartz crystal units Pre-heating temperature: 160±10°C for 90±10 seconds shall be subjected to standard atmospheric Quartz crystal units which is put on PCB shall be conditions for 1 hour, and measured. through reflow soldering furnace twice with the condition · Without distinct deformation in shown above. appearance. Soldering iron method • Frequency change: Within ±5ppm Terminals shall be applied 400±10°C soldering iron heat Equivalent series resistance(E.S.R) for 3.5±0.5 seconds twice. change: Within 5kΩ · After conditioning, quartz crystal units shall be subjected to standard atmospheric conditions for 1 hour, and measured. · Without distinct deformation in appearance. Solubility to • Without mechanical damage such as Soak cleaning breaks and satisfy sealing specification. resistance Quartz crystal units shall be soaked in isopropyl alcohol at normal temperature for 90 • Frequency change: Within ±5ppm seconds. • Equivalent series resistance(E.S.R) change: Within 5kΩ



· Without distinct deformation in

· Marking shall be legible.

appearance.

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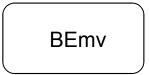
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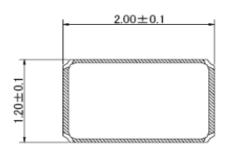
25-Oct-13

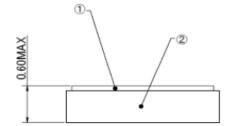
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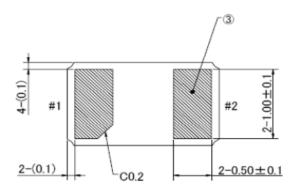


Dimensions (Units: mm)

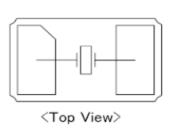




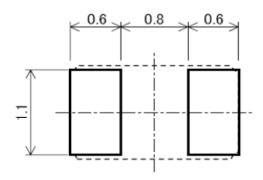








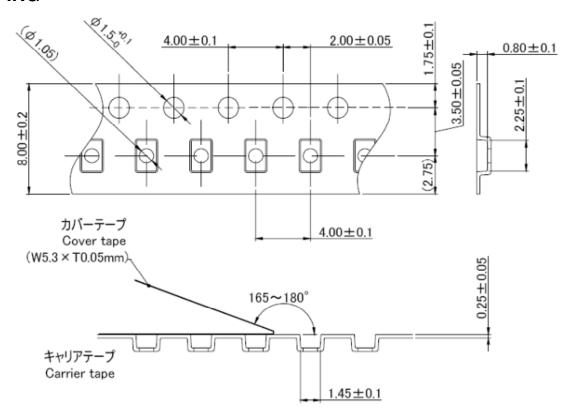
Land dimensions(unit: mm)



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TAPING



REEL

